

Search Notes

Application/Control No.

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Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

DAURA LUNA ET AL.

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	435	7/18/2007	JAT
	436	7/18/2007	JAT
	903	7/18/2007	JAT
180	167	7/18/2007	JAT
	169	7/18/2007	JAT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR